# **ELPIDA**

#### **DATA SHEET**

## 2GB Unbuffered DDR2 SDRAM DIMM

# EBE21EE8ACFA (256M words × 72 bits, 2 Ranks)

#### **Specifications**

Density: 2GBOrganization

256M words × 72 bits, 2 ranks

 Mounting 18 pieces of 1G bits DDR2 SDRAM sealed in FBGA

 Package: 240-pin socket type dual in line memory module (DIMM)

PCB height: 30.0mmLead pitch: 1.0mm

Lead-free (RoHS compliant)
 Power supply: VDD = 1.8V ± 0.1V
 Data rate: 800Mbps/667Mbps (max.)

 Eight internal banks for concurrent operation (components)

Interface: SSTL\_18
Burst lengths (BL): 4, 8
/CAS Latency (CL): 3, 4, 5, 6

Precharge: auto precharge option for each burst access

Refresh: auto-refresh, self-refreshRefresh cycles: 8192 cycles/64ms

Average refresh period
 7.8μs at 0°C ≤ TC ≤ +85°C
 3.9μs at +85°C < TC ≤ +95°C</li>

• Operating case temperature range

- TC = 0°C to +95°C

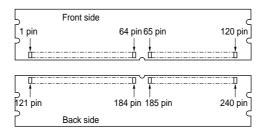
#### **Features**

- Double-data-rate architecture; two data transfers per clock cycle
- The high-speed data transfer is realized by the 4 bits prefetch pipelined architecture
- Bi-directional differential data strobe (DQS and /DQS) is transmitted/received with data for capturing data at the receiver
- DQS is edge-aligned with data for READs; centeraligned with data for WRITEs
- Differential clock inputs (CK and /CK)
- DLL aligns DQ and DQS transitions with CK transitions
- Commands entered on each positive CK edge; data and data mask referenced to both edges of DQS
- Data mask (DM) for write data
- Posted /CAS by programmable additive latency for better command and data bus efficiency
- Off-Chip-Driver Impedance Adjustment and On-Die-Termination for better signal quality
- /DQS can be disabled for single-ended Data Strobe operation

## **Ordering Information**

Part number	Data rate Mbps (max.)	Component JEDEC speed bin (CL-tRCD-tRP)	Package	Contact pad	Mounted devices
EBE21EE8ACFA-8E-E	800	DDR2-800 (5-5-5)			EDE1108ACSE-8E-E
EBE21EE8ACFA-8G-E	<del>_</del> "	DDR2-800 (6-6-6)	240-pin DIMM — (lead-free)	Gold	EDE1108ACSE-8E-E
EBE21EE8ACFA-6E-E	667	DDR2-667 (5-5-5)	— (leau-liee)		EDE1108ACSE-8E-E EDE1108ACSE-6E-E

## **Pin Configurations**



1         VREF         61         A4         121         VSS         181         VDD           2         VSS         62         VDD         122         DQ4         182         A3           3         DQ0         63         A2         123         DQ5         183         A1           4         DQ1         64         VDD         124         VSS         184         VDD           5         VSS         65         VSS         125         DM0         185         CK0           6         //DQS0         66         VSS         126         NC         186         //CK0           7         DQS0         67         VDD         127         VSS         187         VDD           8         VSS         68         NC         128         DQ6         188         A0           9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD	Pin No.	Pin name						
3         DQ0         63         A2         123         DQ5         183         A1           4         DQ1         64         VDD         124         VSS         184         VDD           5         VSS         65         VSS         125         DM0         185         CK0           6         //DQS0         66         VSS         126         NC         186         /CK0           7         DQS0         67         VDD         127         VSS         187         VDD           8         VSS         68         NC         128         DQ6         188         A0           9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         //RAS           13         DQ9         73         /WE         133         VSS         193         /CS0	1	VREF	61	A4	121	VSS	181	VDD
4         DQ1         64         VDD         124         VSS         184         VDD           5         VSS         65         VSS         125         DM0         185         CK0           6         //DQS0         66         VSS         126         NC         186         //CK0           7         DQS0         67         VDD         127         VSS         187         VDD           8         VSS         68         NC         128         DQ6         188         A0           9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         //RAS           13         DQ9         73         //WE         133         VSS         193         //CS0           14         VSS         74         //CAS         134         DM1         194         VDD	2	VSS	62	VDD	122	DQ4	182	A3
5         VSS         65         VSS         125         DM0         185         CK0           6         //DQS0         66         VSS         126         NC         186         //CK0           7         DQS0         67         VDD         127         VSS         187         VDD           8         VSS         68         NC         128         DQ6         188         A0           9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         //RAS           13         DQ9         73         //VE         133         VSS         193         //CS0           14         VSS         74         //CAS         134         DM1         194         VDD           15         //DQS1         75         VDD         135         NC         195         ODT0 </td <td>3</td> <td>DQ0</td> <td>63</td> <td>A2</td> <td>123</td> <td>DQ5</td> <td>183</td> <td>A1</td>	3	DQ0	63	A2	123	DQ5	183	A1
6         /DQS0         66         VSS         126         NC         186         /CK0           7         DQS0         67         VDD         127         VSS         187         VDD           8         VSS         68         NC         128         DQ6         188         A0           9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         /RAS           13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13	4	DQ1	64	VDD	124	VSS	184	VDD
7         DQS0         67         VDD         127         VSS         187         VDD           8         VSS         68         NC         128         DQ6         188         A0           9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         /RAS           13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD	5	VSS	65	VSS	125	DM0	185	CK0
8         VSS         68         NC         128         DQ6         188         A0           9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         /RAS           13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS	6	/DQS0	66	VSS	126	NC	186	/CK0
9         DQ2         69         VDD         129         DQ7         189         VDD           10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         /RAS           13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36 <td>7</td> <td>DQS0</td> <td>67</td> <td>VDD</td> <td>127</td> <td>VSS</td> <td>187</td> <td>VDD</td>	7	DQS0	67	VDD	127	VSS	187	VDD
10         DQ3         70         A10/AP         130         VSS         190         BA1           11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         /RAS           13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         //DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37	8	VSS	68	NC	128	DQ6	188	A0
11         VSS         71         BA0         131         DQ12         191         VDD           12         DQ8         72         VDD         132         DQ13         192         /RAS           13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS	9	DQ2	69	VDD	129	DQ7	189	VDD
12         DQ8         72         VDD         132         DQ13         192         /RAS           13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4	10	DQ3	70	A10/AP	130	VSS	190	BA1
13         DQ9         73         /WE         133         VSS         193         /CS0           14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQ84         143         DQ20         203         NC	11	VSS	71	BA0	131	DQ12	191	VDD
14         VSS         74         /CAS         134         DM1         194         VDD           15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQ84         143         DQ20         203         NC           24         DQ16         84         DQ84         144         DQ21         204         VSS	12	DQ8	72	VDD	132	DQ13	192	/RAS
15         /DQS1         75         VDD         135         NC         195         ODT0           16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQS4         143         DQ20         203         NC           24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38	13	DQ9	73	/WE	133	VSS	193	/CS0
16         DQS1         76         /CS1         136         VSS         196         A13           17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQS4         143         DQ20         203         NC           24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	14	VSS	74	/CAS	134	DM1	194	VDD
17         VSS         77         ODT1         137         CK1         197         VDD           18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQS4         143         DQ20         203         NC           24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	15	/DQS1	75	VDD	135	NC	195	ODT0
18         NC         78         VDD         138         /CK1         198         VSS           19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQS4         143         DQ20         203         NC           24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	16	DQS1	76	/CS1	136	VSS	196	A13
19         NC         79         VSS         139         VSS         199         DQ36           20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQS4         143         DQ20         203         NC           24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	17	VSS	77	ODT1	137	CK1	197	VDD
20         VSS         80         DQ32         140         DQ14         200         DQ37           21         DQ10         81         DQ33         141         DQ15         201         VSS           22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQS4         143         DQ20         203         NC           24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	18	NC	78	VDD	138	/CK1	198	VSS
21       DQ10       81       DQ33       141       DQ15       201       VSS         22       DQ11       82       VSS       142       VSS       202       DM4         23       VSS       83       /DQS4       143       DQ20       203       NC         24       DQ16       84       DQS4       144       DQ21       204       VSS         25       DQ17       85       VSS       145       VSS       205       DQ38         26       VSS       86       DQ34       146       DM2       206       DQ39	19	NC	79	VSS	139	VSS	199	DQ36
22         DQ11         82         VSS         142         VSS         202         DM4           23         VSS         83         /DQS4         143         DQ20         203         NC           24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	20	VSS	80	DQ32	140	DQ14	200	DQ37
23       VSS       83       /DQS4       143       DQ20       203       NC         24       DQ16       84       DQS4       144       DQ21       204       VSS         25       DQ17       85       VSS       145       VSS       205       DQ38         26       VSS       86       DQ34       146       DM2       206       DQ39	21	DQ10	81	DQ33	141	DQ15	201	VSS
24         DQ16         84         DQS4         144         DQ21         204         VSS           25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	22	DQ11	82	VSS	142	VSS	202	DM4
25         DQ17         85         VSS         145         VSS         205         DQ38           26         VSS         86         DQ34         146         DM2         206         DQ39	23	VSS	83	/DQS4	143	DQ20	203	NC
26 VSS 86 DQ34 146 DM2 206 DQ39	24	DQ16	84	DQS4	144	DQ21	204	VSS
	25	DQ17	85	VSS	145	VSS	205	DQ38
27 /DQS2 87 DQ35 147 NC 207 VSS	26	VSS	86	DQ34	146	DM2	206	DQ39
	27	/DQS2	87	DQ35	147	NC	207	VSS

**ELPID**A

## EBE21EE8ACFA

Pin No.	Pin name						
28	DQS2	88	VSS	148	VSS	208	DQ44
29	VSS	89	DQ40	149	DQ22	209	DQ45
30	DQ18	90	DQ41	150	DQ23	210	VSS
31	DQ19	91	VSS	151	VSS	211	DM5
32	VSS	92	/DQS5	152	DQ28	212	NC
33	DQ24	93	DQS5	153	DQ29	213	VSS
34	DQ25	94	VSS	154	VSS	214	DQ46
35	VSS	95	DQ42	155	DM3	215	DQ47
36	/DQS3	96	DQ43	156	NC	216	VSS
37	DQS3	97	VSS	157	VSS	217	DQ52
38	VSS	98	DQ48	158	DQ30	218	DQ53
39	DQ26	99	DQ49	159	DQ31	219	VSS
40	DQ27	100	VSS	160	VSS	220	CK2
41	VSS	101	SA2	161	CB4	221	/CK2
42	CB0	102	NC	162	CB5	222	VSS
43	CB1	103	VSS	163	VSS	223	DM6
44	VSS	104	/DQS6	164	DM8	224	NC
45	/DQS8	105	DQS6	165	NC	225	VSS
46	DQS8	106	VSS	166	VSS	226	DQ54
47	VSS	107	DQ50	167	CB6	227	DQ55
48	CB2	108	DQ51	168	CB7	228	VSS
49	CB3	109	VSS	169	VSS	229	DQ60
50	VSS	110	DQ56	170	VDD	230	DQ61
51	VDD	111	DQ57	171	CKE1	231	VSS
52	CKE0	112	VSS	172	VDD	232	DM7
53	VDD	113	/DQS7	173	NC	233	NC
54	BA2	114	DQS7	174	NC	234	VSS
55	NC	115	VSS	175	VDD	235	DQ62
56	VDD	116	DQ58	176	A12	236	DQ63
57	A11	117	DQ59	177	A9	237	VSS
58	A7	118	VSS	178	VDD	238	VDDSPD
59	VDD	119	SDA	179	A8	239	SA0
60	A5	120	SCL	180	A6	240	SA1



## **Pin Description**

Pin name	Function
A0 to A13	Address input Row address A0 to A13 Column address A0 to A9
A10 (AP)	Auto precharge
BA0, BA1, BA2	Bank select address
DQ0 to DQ63	Data input/output
CB0 to CB7	Check bit (Data input/output)
/RAS	Row address strobe command
/CAS	Column address strobe command
WE	Write enable
/CS0, /CS1	Chip select
CKE0, CKE1	Clock enable
CK0 to CK2	Clock input
/CK0 to /CK2	Differential clock input
DQS0 to DQS8, /DQS0 to /DQS8	Input and output data strobe
DM0 to DM8	Input mask
SCL	Clock input for serial PD
SDA	Data input/output for serial PD
SA0 to SA2	Serial address input
VDD	Power for internal circuit
VDDSPD	Power for serial EEPROM
VREF	Input reference voltage
VSS	Ground
ODT0, ODT1	ODT control
NC	No connection



## **Serial PD Matrix**

Byte No.	Function described	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	Hex value	Comments
0	Number of bytes utilized by module manufacturer	1	0	0	0	0	0	0	0	80H	128 bytes
1	Total number of bytes in serial PD device	0	0	0	0	1	0	0	0	08H	256 bytes
2	Memory type	0	0	0	0	1	0	0	0	08H	DDR2 SDRAM
3	Number of row address	0	0	0	0	1	1	1	0	0EH	14
4	Number of column address	0	0	0	0	1	0	1	0	0AH	10
5	Number of DIMM ranks	0	1	1	0	0	0	0	1	61H	2
6	Module data width	0	1	0	0	1	0	0	0	48H	72
7	Module data width continuation	0	0	0	0	0	0	0	0	00H	0
8	Voltage interface level of this assembly	0	0	0	0	0	1	0	1	05H	SSTL 1.8V
9	DDR SDRAM cycle time, CL = X -8E (CL = 5)	0	0	1	0	0	1	0	1	25H	2.5ns* <sup>1</sup>
	-8G (CL = 6)	0	0	1	0	0	1	0	1	25H	2.5ns* <sup>1</sup>
	-6E (CL = 5)	0	0	1	1	0	0	0	0	30H	3.0ns* <sup>1</sup>
10	SDRAM access from clock (tAC) -8E, -8G	0	1	0	0	0	0	0	0	40H	0.4ns* <sup>1</sup>
	-6E	0	1	0	0	0	1	0	1	45H	0.45ns* <sup>1</sup>
11	DIMM configuration type	0	0	0	0	0	0	1	0	02H	ECC
12	Refresh rate/type	1	0	0	0	0	0	1	0	82H	7.8μs
13	Primary SDRAM width	0	0	0	0	1	0	0	0	08H	×8
14	Error checking SDRAM width	0	0	0	0	1	0	0	0	08H	× 8
15	Reserved	0	0	0	0	0	0	0	0	00H	0
16	SDRAM device attributes: Burst length supported	0	0	0	0	1	1	0	0	0CH	4,8
17	SDRAM device attributes: Number of banks on SDRAM device	0	0	0	0	1	0	0	0	08H	8
18	SDRAM device attributes: /CAS latency -8E, -6E	0	0	1	1	1	0	0	0	38H	3, 4, 5
	-8G	0	1	1	1	0	0	0	0	70H	4, 5, 6
19	DIMM Mechanical Characteristics	0	0	0	0	0	0	0	1	01H	4.00mm max.
20	DIMM type information	0	0	0	0	0	0	1	0	02H	Unbuffered
21	SDRAM module attributes	0	0	0	0	0	0	0	0	00H	Normal
22	SDRAM device attributes: General	0	0	0	0	0	0	1	1	03H	Weak Driver 50Ω ODT Support
23	Minimum clock cycle time at CL = X - 1 -8E, -6E (CL = 4)	0	0	1	1	1	1	0	1	3DH	3.75ns* <sup>1</sup>
	-8G (CL = 5)	0	0	1	1	0	0	0	0	30H	3.0ns* <sup>1</sup>
24	Maximum data access time (tAC) from clock at CL = X - 1 -8E, -6E (CL = 4)	0	1	0	1	0	0	0	0	50H	0.5ns* <sup>1</sup>
	-8G (CL = 5)	0	1	0	0	0	1	0	1	45H	0.45ns* <sup>1</sup>
25	Minimum clock cycle time at CL = X - 2 -8E, -6E (CL = 3)	0	1	0	1	0	0	0	0	50H	5.0ns* <sup>1</sup>
	-8G (CL = 4)	0	0	1	1	1	1	0	1	3DH	3.75ns*1



Byte No.	Function described	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0	Hex value	Comments
26	Maximum data access time (tAC) from clock at CL = X - 2 -8E, -6E (CL = 3)	0	1	1	0	0	0	0	0	60H	0.6ns* <sup>1</sup>
	-8G (CL = 4)	0	1	0	1	0	0	0	0	50H	0.5ns* <sup>1</sup>
27	Minimum row precharge time (tRP) -8E	0	0	1	1	0	0	1	0	32H	12.5ns
	-8G, -6E	0	0	1	1	1	1	0	0	3CH	15ns
28	Minimum row active to row active delay (tRRD)	0	0	0	1	1	1	1	0	1EH	7.5ns
29	Minimum /RAS to /CAS delay (tRCD) -8E	U	0	1	1	0	0	1	0	32H	12.5ns
	-8G, -6E	0	0	1	1	1	1	0	0	3CH	15ns
30	Minimum active to precharge time (tRAS)	0	0	1	0	1	1	0	1	2DH	45ns
31	Module rank density	0	0	0	0	0	0	0	1	01H	1G bytes
32	Address and command setup time before clock (tIS) -8E, -8G	0	0	0	1	0	1	1	1	17H	0.17ns*1
	-6E	0	0	1	0	0	0	0	0	20H	0.20ns* <sup>1</sup>
33	Address and command hold time after clock (tlH) -8E, -8G	0	0	1	0	0	1	0	1	25H	0.25ns* <sup>1</sup>
	-6E	0	0	1	0	0	1	1	1	27H	0.27ns* <sup>1</sup>
34	Data input setup time before clock (tDS) -8E, -8G	0	0	0	0	0	1	0	1	05H	0.05ns* <sup>1</sup>
	-6E	0	0	0	1	0	0	0	0	10H	0.10ns* <sup>1</sup>
35	Data input hold time after clock (tDH) -8E, -8G	0	0	0	1	0	0	1	0	12H	0.12ns* <sup>1</sup>
	-6E	0	0	0	1	0	1	1	1	17H	0.17ns*1
36	Write recovery time (tWR)	0	0	1	1	1	1	0	0	3CH	15ns* <sup>1</sup>
37	Internal write to read command delay (tWTR)	0	0	0	1	1	1	1	0	1EH	7.5ns* <sup>1</sup>
38	Internal read to precharge command delay (tRTP)	0	0	0	1	1	1	1	0	1EH	7.5ns* <sup>1</sup>
39	Memory analysis probe characteristics	0	0	0	0	0	0	0	0	00H	TBD
40	Extension of Byte 41 and 42 -8E	0	0	1	1	0	1	1	0	36H	
	-8G, -6E	0	0	0	0	0	1	1	0	06H	
41	Active command period (tRC) -8E	0	0	1	1	1	0	0	1	39H	57.5ns* <sup>1</sup>
	-8G, -6E	0	0	1	1	1	1	0	0	3CH	60ns*1
42	Auto refresh to active/ Auto refresh command cycle (tRFC)	0	1	1	1	1	1	1	1	7FH	127.5ns* <sup>1</sup>
43	SDRAM tCK cycle max. (tCK max.)	1	0	0	0	0	0	0	0	80H	8ns*1
44	Dout to DQS skew -8E, -8G	0	0	0	1	0	1	0	0	14H	0.20ns* <sup>1</sup>
	-6E	0	0	0	1	1	0	0	0	18H	0.24ns*1
45	Data hold skew (tQHS) -8E, -8G	0	0	0	1	1	1	1	0	1EH	0.30ns* <sup>1</sup>
	-6E	0	0	1	0	0	0	1	0	22H	0.34ns* <sup>1</sup>
46	PLL relock time	0	0	0	0	0	0	0	0	00H	Undefined

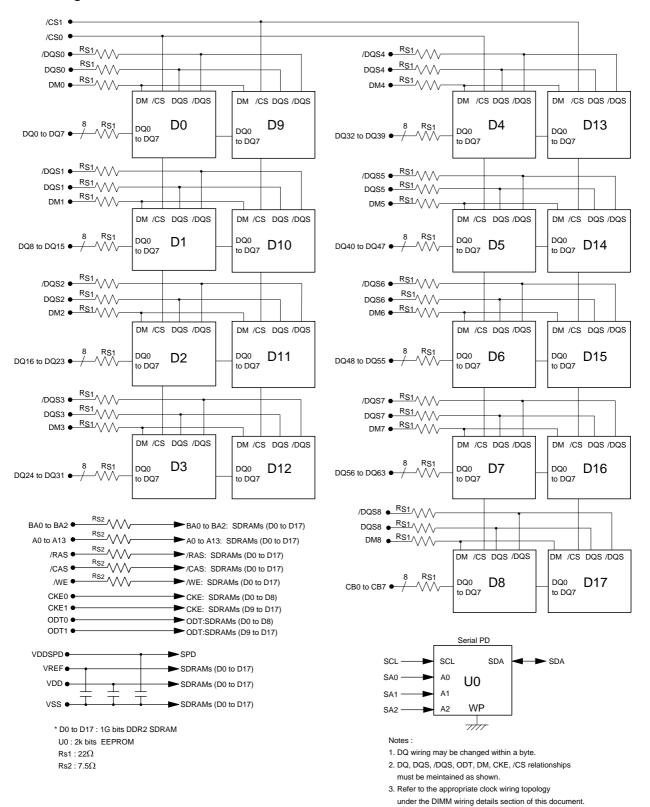


47 to 61											Comments
		0	0	0	0	0	0	0	0	00H	
62	SPD Revision	0	0	0	1	0	0	1	0	12H	Rev. 1.2
63	Checksum for bytes 0 to 62 -8E	0	0	0	0	1	0	1	1	0BH	
	-8G	1	1	1	0	1	1	1	1	EFH	
	-6E	0	0	1	0	0	1	0	1	25H	
64 to 65	Manufacturer's JEDEC ID code	0	1	1	1	1	1	1	1	7FH	Continuation code
66	Manufacturer's JEDEC ID code	1	1	1	1	1	1	1	0	FEH	Elpida Memory
67 to 71	Manufacturer's JEDEC ID code	0	0	0	0	0	0	0	0	00H	
72	Manufacturing location	×	×	×	×	×	×	×	×	××	(ASCII-8bit code)
73	Module part number	0	1	0	0	0	1	0	1	45H	E
74	Module part number	0	1	0	0	0	0	1	0	42H	В
75	Module part number	0	1	0	0	0	1	0	1	45H	E
76	Module part number	0	0	1	1	0	0	1	0	32H	2
77	Module part number	0	0	1	1	0	0	0	1	31H	1
78	Module part number	0	1	0	0	0	1	0	1	45H	E
79	Module part number	0	1	0	0	0	1	0	1	45H	E
80	Module part number	0	0	1	1	1	0	0	0	38H	8
81	Module part number	0	1	0	0	0	0	0	1	41H	Α
82	Module part number	0	1	0	0	0	0	1	1	43H	С
83	Module part number	0	1	0	0	0	1	1	0	46H	F
84	Module part number	0	1	0	0	0	0	0	1	41H	Α
85	Module part number	0	0	1	0	1	1	0	1	2DH	_
86	Module part number -8E, -8G	0	0	1	1	1	0	0	0	38H	8
	-6E	0	0	1	1	0	1	1	0	36H	6
87	Module part number -8E, -6E	0	1	0	0	0	1	0	1	45H	Е
	-8G	0	1	0	0	0	1	1	1	47H	G
88	Module part number	0	0	1	0	1	1	0	1	2DH	_
89	Module part number	0	1	0	0	0	1	0	1	45H	E
90	Module part number	0	0	1	0	0	0	0	0	20H	(Space)
91	Revision code	0	0	1	1	0	0	0	0	30H	Initial
92	Revision code	0	0	1	0	0	0	0	0	20H	(Space)
93	Manufacturing date	×	×	×	×	×	×	×	×	××	Year code (BCD)
94	Manufacturing date	×	×	×	×	×	×	×	×	××	Week code (BCD)
95 to 98	Module serial number										
99 to 127	Manufacture specific data										

Note 1: These specifications are defined based on component specification, not module.

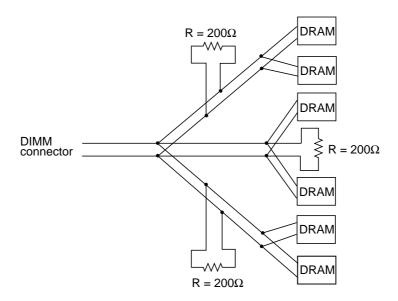
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#### **Block Diagram**



## **Logical Clock Net Structure**

## 6DRAM loads



#### **Electrical Specifications**

• All voltages are referenced to VSS (GND).

#### **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit	Notes	
Voltage on any pin relative to VSS	VT	-0.5 to +2.3	V	1	
Supply voltage relative to VSS	VDD	-0.5 to +2.3	V		
Short circuit output current	IOS	50	mA	1	
Power dissipation	PD	9	W		
Operating case temperature	TC	0 to +95	°C	1, 2	
Storage temperature	Tstg	-55 to +100	°C	1	

Notes: 1. DDR2 SDRAM component specification.

2. Supporting 0°C to +85°C and being able to extend to +95°C with doubling auto-refresh commands in frequency to a 32ms period (tREFI =  $3.9\mu s$ ) and higher temperature self-refresh entry via the control of EMRS (2) bit A7 is required.

## Caution

Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

#### DC Operating Conditions (TC = 0°C to +85°C) (DDR2 SDRAM Component Specification)

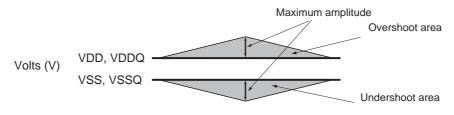
Parameter	Symbol	min.	typ.	max.	Unit	Notes
Supply voltage	VDD, VDDQ	1.7	1.8	1.9	V	4
	VSS	0	0	0	V	
	VDDSPD	1.7	_	3.6	V	
Input reference voltage	VREF	0.49 × VDDQ	$0.50 \times VDDQ$	$0.51 \times VDDQ$	V	1, 2
Termination voltage	VTT	VREF - 0.04	VREF	VREF + 0.04	V	3
DC input logic high	VIH (DC)	VREF + 0.125	_	VDDQ + 0.3	V	
DC input low	VIL (DC)	-0.3	_	VREF - 0.125	V	
AC input logic high	VIH (AC)	VREF + 0.200	_	_	V	
AC input low	VIL (AC)	_	_	VREF - 0.200	V	

Notes: 1. The value of VREF may be selected by the user to provide optimum noise margin in the system. Typically the value of VREF is expected to be about  $0.5 \times VDDQ$  of the transmitting device and VREF are expected to track variations in VDDQ.

- 2. Peak to peak AC noise on VREF may not exceed ±2% VREF (DC).
- 3. VTT of transmitting device must track VREF of receiving device.
- 4. VDDQ must be equal to VDD.

## AC Overshoot/Undershoot Specification (DDR2 SDRAM Component Specification)

Parameter	Pins	Specification	Unit
Maximum peak amplitude allowed for overshoot	Command, Address, CKE, ODT	0.5	V
Maximum peak amplitude allowed for undershoot		0.5	V
Maximum overshoot area above VDD DDR2-800		0.66	V-ns
DDR2-667		0.8	V-ns
Maximum undershoot area below VSS DDR2-800		0.66	V-ns
DDR2-667		0.8	V-ns
Maximum peak amplitude allowed for overshoot	CK, /CK	0.5	V
Maximum peak amplitude allowed for undershoot		0.5	V
Maximum overshoot area above VDD		0.23	V-ns
Maximum undershoot area below VSS		0.23	V-ns
Maximum peak amplitude allowed for overshoot	DQ, DQS, /DQS,	0.5	V
Maximum peak amplitude allowed for undershoot	UDQS, /UDQS, LDQS, /LDQS,	0.5	V
Maximum overshoot area above VDDQ	RDQS, /RDQS, DM, UDM, LDM	0.23	V-ns
Maximum undershoot area below VSSQ		0.23	V-ns



Time (ns)

Overshoot/Undershoot Definition

## DC Characteristics 1 (TC = 0°C to +85°C, VDD = 1.8V $\pm$ 0.1V, VSS = 0V)

Parameter	Symbol	Grade	max.	Unit	Test condition			
Operating current (ACT-PRE) (Another rank is in IDD2P)	IDD0	-8E, -8G -6E	855 810	mA	one bank; tCK = tCK (IDD), tRC = tRC (IDD), tRAS = tRAS min.(IDD); — CKE is H, /CS is H between valid commands; Address bus inputs are SWITCHING; Data bus inputs are SWITCHING			
Operating current (ACT-PRE) (Another rank is in IDD3N)	IDD0	-8E, -8G -6E	1575 1440	mA				
Operating current (ACT-READ-PRE) (Another rank is in IDD2P)	IDD1	-8E, -8G -6E	990 945	mA	one bank; IOUT = 0mA; BL = 4, CL = CL(IDD), AL = 0; tCK = tCK (IDD), tRC = tRC (IDD),			
Operating current (ACT-READ-PRE) (Another rank is in IDD3N)	IDD1	-8E, -8G -6E	1710 1575	mA	<ul> <li>tRAS = tRAS min.(IDD); tRCD = CKE is H, /CS is H between valid Address bus inputs are SWITCH Data pattern is same as IDD4W</li> </ul>	d commands;		
Precharge power-down standby current	IDD2P		180	mA	all banks idle; tCK = tCK (IDD); CKE is L; Other control and address bus inputs are STABLE; Data bus inputs are FLOATING			
Precharge quiet standby current	IDD2Q	-8E, -8G -6E	630 540	mA	all banks idle; tCK = tCK (IDD); CKE is H, /CS is H; Other control and address bus inputs are STABLE; Data bus inputs are FLOATING			
Idle standby current	IDD2N	-8E, -8G -6E	720 630	mA	all banks idle; tCK = tCK (IDD); CKE is H, /CS is H; Other control and address bus inputs are SWITCHING. Data bus inputs are SWITCHING			
Active power-down	IDD3P-F	-8E, -8G -6E	630	mA	all banks open; tCK = tCK (IDD); CKE is L;	Fast PDN Exit MRS(12) = 0		
standby current	IDD3P-S	1	360	mA	Other control and address bus inputs are STABLE; Data bus inputs are FLOATING	Slow PDN Exit MRS(12) = 1		
Active standby current	IDD3N	-8E, -8G -6E	1620 1440	mA	all banks open; tCK = tCK (IDD), tRAS = tRAS max.(IDD), tRP = tRP CKE is H, /CS is H between valid commands; Other control and address bus inputs are SWITCHING Data bus inputs are SWITCHING			
Operating current (Burst read operating) (Another rank is in IDD2P)	IDD4R	-8E, -8G -6E	1530 1350	mA	tCK = tCK (IDD), tRAS = tRAS max.(IDD), tRP = tRP (II CKE is H, /CS is H between valid commands;			
Operating current (Burst read operating) (Another rank is in IDD3N)	IDD4R	-8E, -8G -6E	2250 1980	mA				
Operating current (Burst write operating) (Another rank is in IDD2P)	IDD4W	-8E, -8G -6E	1530 1350	mA	tCK = tCK (IDD), tRAS = tRAS max.(IDD), tRP = tRP (II CKE is H, /CS is H between valid commands;			
Operating current (Burst write operating) (Another rank is in IDD3N)	IDD4W	-8E, -8G -6E	2250 1980	mA				



Parameter	Symbol	Grade	max.	Unit	Test condition
Auto-refresh current (Another rank is in IDD2P)	IDD5	-8E, -8G -6E	2700 2610	mA	tCK = tCK (IDD); Refresh command at every tRFC (IDD) interval; – CKE is H, /CS is H between valid commands;
Auto-refresh current (Another rank is in IDD3N)	IDD5	-8E, -8G -6E	3420 3240	mA	Other control and address bus inputs are SWITCHING; Data bus inputs are SWITCHING
Self-refresh current	IDD6		180	mA	Self Refresh Mode; CK and /CK at 0V; CKE ≤ 0.2V; Other control and address bus inputs are FLOATING; Data bus inputs are FLOATING
Operating current (Bank interleaving) (Another rank is in IDD2P)	IDD7	-8E, -8G -6E	2700 2565	mA	all bank interleaving reads, IOUT = 0mA; BL = 4, CL = CL(IDD), AL = tRCD (IDD) -1 × tCK (IDD); tCK = tCK (IDD), tRC = tRC (IDD), tRRD = tRRD(IDD), -tFAW = tFAW (IDD), tRCD = 1 × tCK (IDD);
Operating current (Bank interleaving) (Another rank is in IDD3N)	IDD7	-8E, -8G -6E	3420 3195	mA	CKE is H, /CS is H between valid commands; Address bus inputs are STABLE during DESELECTs; Data pattern is same as IDD4W;

Notes: 1. IDD specifications are tested after the device is properly initialized.

- 2. Input slew rate is specified by AC Input Test Condition.
- 3. IDD parameters are specified with ODT disabled.
- 4. Data bus consists of DQ, DM, DQS, /DQS, RDQS and /RDQS. IDD values must be met with all combinations of EMRS bits 10 and 11.
- 5. Definitions for IDD

L is defined as VIN ≤ VIL (AC) (max.)

H is defined as VIN ≥ VIH (AC) (min.)

STABLE is defined as inputs stable at an H or L level

FLOATING is defined as inputs at VREF = VDDQ/2

SWITCHING is defined as:

inputs changing between H and L every other clock cycle (once per two clocks) for address and control signals, and inputs changing between H and L every other data transfer (once per clock) for DQ signals not including masks or strobes.

6. Refer to AC Timing for IDD Test Conditions.



## **AC Timing for IDD Test Conditions**

For purposes of IDD testing, the following parameters are to be utilized.

	DDR2-800	DDR2-800	DDR2-667	
Parameter	5-5-5	6-6-6	5-5-5	Unit
CL (IDD)	5	6	5	tCK
tRCD (IDD)	12.5	15	15	ns
tRC (IDD)	57.5	60	60	ns
tRRD (IDD)	7.5	7.5	7.5	ns
tFAW (IDD)	35	35	37.5	ns
tCK (IDD)	2.5	2.5	3	ns
tRAS (min.)(IDD)	45	45	45	ns
tRAS (max.)(IDD)	70000	70000	70000	ns
tRP (IDD)	12.5	15	15	ns
tRFC (IDD)	127.5	127.5	127.5	ns
· · · · · · · · · · · · · · · · · · ·	·	·	·	



## DC Characteristics 2 (TC = 0°C to +85°C, VDD, VDDQ = 1.8V $\pm$ 0.1V)

## (DDR2 SDRAM Component Specification)

Parameter	Symbol	Value	Unit	Notes
Input leakage current	ILI	2	μΑ	$VDD \geq VIN \geq VSS$
Output leakage current	ILO	5	μΑ	$VDDQ \ge VOUT \ge VSS$
Minimum required output pull-up under AC test load	VOH	VTT + 0.603	V	5
Maximum required output pull-down under AC test load	VOL	VTT - 0.603	V	5
Output timing measurement reference level	VOTR	$0.5 \times \text{VDDQ}$	V	1
Output minimum sink DC current	IOL	+13.4	mA	3, 4, 5
Output minimum source DC current	IOH	-13.4	mA	2, 4, 5

Notes: 1. The VDDQ of the device under test is referenced.

- 2. VDDQ = 1.7V; VOUT = 1.42V.
- 3. VDDQ = 1.7V; VOUT = 0.28V.
- 4. The DC value of VREF applied to the receiving device is expected to be set to VTT.
- 5. After OCD calibration to  $18\Omega$  at TC =  $25^{\circ}$ C, VDD = VDDQ = 1.8V.

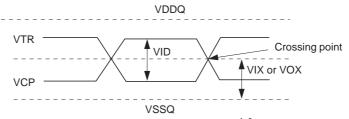
## DC Characteristics 3 (TC = 0°C to +85°C, VDD, VDDQ = $1.8V \pm 0.1V$ )

## (DDR2 SDRAM Component Specification)

Parameter	Symbol	min.	max.	Unit	Notes
AC differential input voltage	VID (AC)	0.5	VDDQ + 0.6	V	1, 2
AC differential cross point voltage	VIX (AC)	0.5 × VDDQ – 0.175	$0.5 \times VDDQ + 0.175$	V	2
AC differential cross point voltage	VOX (AC)	0.5 × VDDQ – 0.125	0.5 × VDDQ + 0.125	V	3

Notes: 1. VID (AC) specifies the input differential voltage |VTR -VCP| required for switching, where VTR is the true input signal (such as CK, DQS, RDQS) and VCP is the complementary input signal (such as /CK, /DQS, /RDQS). The minimum value is equal to VIH (AC) – VIL (AC).

- The typical value of VIX (AC) is expected to be about 0.5 × VDDQ of the transmitting device and VIX (AC) is expected to track variations in VDDQ. VIX (AC) indicates the voltage at which differential input signals must cross.
- 3. The typical value of VOX (AC) is expected to be about  $0.5 \times \text{VDDQ}$  of the transmitting device and VOX (AC) is expected to track variations in VDDQ. VOX (AC) indicates the voltage at which differential output signals must cross.



Differential Signal Levels\*1,2

**ELPIDA** 

# ODT DC Electrical Characteristics (TC = $0^{\circ}$ C to +85°C, VDD, VDDQ = $1.8V \pm 0.1V$ ) (DDR2 SDRAM Component Specification)

Parameter	Symbol	min.	typ.	max.	Unit	Note
Rtt effective impedance value for EMRS (A6, A2) = 0, 1; 75 $\Omega$	Rtt1(eff)	60	75	90	Ω	1
Rtt effective impedance value for EMRS (A6, A2) = 1, 0; 150 $\Omega$	Rtt2(eff)	120	150	180	Ω	1
Rtt effective impedance value for EMRS (A6, A2) = 1, 1; 50 $\Omega$	Rtt3(eff)	40	50	60	Ω	1
Deviation of VM with respect to VDDQ/2	ΔVM	-6	_	+6	%	1

Note: 1. Test condition for Rtt measurements.

#### Measurement Definition for Rtt (eff)

Apply VIH (AC) and VIL (AC) to test pin separately, then measure current I(VIH (AC)) and I(VIL (AC)) respectively. VIH (AC), and VDDQ values defined in SSTL 18.

$$Rtt(eff) = \frac{VIH(AC) - VIL(AC)}{I(VIH(AC)) - I(VIL(AC))}$$

#### Measurement Definition for ∆VM

Measure voltage (VM) at test pin (midpoint) with no load.

$$\Delta VM = \left(\frac{2 \times VM}{VDDQ} - 1\right) \times 100$$

## OCD Default Characteristics (TC = 0°C to +85°C, VDD, VDDQ = 1.8V $\pm$ 0.1V)

#### (DDR2 SDRAM Component Specification)

Parameter	min.	typ.	max.	Unit	Notes	
Output impedance	12.6	18	23.4	Ω	1, 5	
Pull-up and pull-down mismatch	0	_	4	Ω	1, 2	
Output slew rate	1.5	_	5	V/ns	3, 4	

- Notes: 1. Impedance measurement condition for output source DC current: VDDQ = 1.7V; VOUT = 1420mV; (VOUT–VDDQ)/IOH must be less than  $23.4\Omega$  for values of VOUT between VDDQ and VDDQ–280mV. Impedance measurement condition for output sink DC current: VDDQ = 1.7V; VOUT = 280mV; VOUT/IOL must be less than  $23.4\Omega$  for values of VOUT between 0V and 280mV.
  - 2. Mismatch is absolute value between pull up and pull down, both are measured at same temperature and voltage.
  - 3. Slew rate measured from VIL(AC) to VIH(AC).
  - 4. The absolute value of the slew rate as measured from DC to DC is equal to or greater than the slew rate as measured from AC to AC. This is guaranteed by design and characterization.
  - 5. DRAM I/O specifications for timing, voltage, and slew rate are no longer applicable if OCD is changed from default settings.

## Pin Capacitance (TA = $25^{\circ}$ C, VDD = $1.8V \pm 0.1V$ )

## (DDR2 SDRAM Component Specification)

Parameter	Symbol	Pins	min.	max.	Unit	Notes	
CLK input pin capacitance	CCK	CK, /CK	1.0	2.0	pF	1	
Input capacitance -8E, -8G	CIN	/RAS, /CAS, /WE, /CS,	1.0	1.75	pF	1	
-6E		CKE, ODT, Address	1.0	2.0	pF	1	
Input/output pin capacitance	CI/O	DQ, DQS, /DQS, UDQS, /UDQS, LDQS, /LDQS, RDQS, /RDQS, DM, UDM, LDM, CB	2.5	3.5	pF	2	

Notes: 1. Matching within 0.25pF.

2. Matching within 0.50pF.

# AC Characteristics (TC = 0°C to +85°C, VDD, VDDQ = $1.8V \pm 0.1V$ , VSS, VSSQ = 0V) (DDR2 SDRAM Component Specification)

• New units tCK(avg) and nCK, are introduced in DDR2-800 and DDR2-667 tCK(avg): actual tCK(avg) of the input clock under operation. nCK: one clock cycle of the input clock, counting the actual clock edges.

		-8E		-8G		-6E		_	
Speed bin	_	DDR2-800	(5-5-5)	DDR2-800	(6-6-6)	DDR2-667	(5-5-5)	_	
Parameter	Symbol	min.	max.	min.	max.	min.	max.	Unit	Notes
Active to read or write command delay	tRCD	12.5	_	15	_	15	_	ns	
Precharge command period	tRP	12.5	_	15	_	15	_	ns	
Active to active/auto-refresh command time	tRC	57.5	_	60	_	60	_	ns	
DQ output access time from CK, /CK	tAC	-400	+400	-400	+400	-450	+450	ps	10
DQS output access time from CK, /CK	tDQSCK	-350	+350	-350	+350	-400	+400	ps	10
CK high-level width	tCH (avg)	0.48	0.52	0.48	0.52	0.48	0.52	tCK (avg)	13
CK low-level width	tCL(avg)	0.48	0.52	0.48	0.52	0.48	0.52	tCK (avg)	13
CK half period	tHP	Min. (tCL(abs), tCH(abs))	_	Min. (tCL(abs), tCH(abs))	_	Min. (tCL(abs), tCH(abs))	_	ps	6, 13
Clock cycle time (CL = 6)	tCK (avg)	2500	8000	2500	8000	3000	8000	ps	13
(CL = 5)	tCK (avg)	2500	8000	3000	8000	3000	8000	ps	13
(CL = 4)	tCK (avg)	3750	8000	3750	8000	3750	8000	ps	13
(CL = 3)	tCK (avg)	5000	8000	5000	8000	5000	8000	ps	13
DQ and DM input hold time	tDH (base)	125	_	125	_	175	_	ps	5
DQ and DM input setup time	tDS (base)	50	_	50	_	100	_	ps	4
Control and Address input pulse width for each input	tIPW	0.6	_	0.6	_	0.6	_	tCK (avg)	
DQ and DM input pulse width for each input	tDIPW	0.35	_	0.35	_	0.35	_	tCK (avg)	
Data-out high-impedance time from CK,/CK	tHZ	_	tAC max.	_	tAC max.	_	tAC max.	ps	10
DQS, /DQS low-impedance time from CK,/CK	tLZ (DQS)	tAC min.	tAC max.	tAC min.	tAC max.	tAC min.	tAC max.	ps	10
DQ low-impedance time from CK,/CK	tLZ (DQ)	$2 \times tAC min.$	tAC max.	$\begin{array}{c} \text{2} \\ \times  \text{tAC min} \end{array}$	tAC max.	$\begin{array}{c} \text{2} \\ \times  \text{tAC min} \end{array}$	tAC max.	ps	10
DQS-DQ skew for DQS and associated DQ signals	tDQSQ	_	200	_	200	_	240	ps	
DQ hold skew factor	tQHS	_	300	_	300	_	340	ps	7
DQ/DQS output hold time from DQS	tQH	tHP – tQHS		tHP – tQHS		tHP – tQHS		ps	8
DQS latching rising transitions to associated clock edges	tDQSS	-0.25	+0.25	-0.25	+0.25	-0.25	+0.25	tCK (avg)	
DQS input high pulse width	tDQSH	0.35	_	0.35	_	0.35	_	tCK (avg)	
DQS input low pulse width	tDQSL	0.35	_	0.35		0.35		tCK (avg)	
DQS falling edge to CK setup time	tDSS	0.2	_	0.2	_	0.2	_	tCK (avg)	

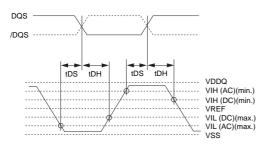


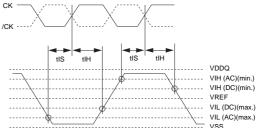
		-8E		-8G		-6E		_	
Speed bin	_	DDR2-800	(5-5-5)	DDR2-800	(6-6-6)	DDR2-667	(5-5-5)	_	
Parameter	Symbol	min.	max.	min.	max.	min.	max.	Unit	Notes
DQS falling edge hold time from CK	tDSH	0.2	_	0.2	_	0.2	_	tCK (avg)	
Mode register set command cycle time	tMRD	2	_	2	_	2	_	nCK	
Write postamble	tWPST	0.4	0.6	0.4	0.6	0.4	0.6	tCK (avg)	
Write preamble	tWPRE	0.35	_	0.35	_	0.35	_	tCK (avg)	
Address and control input hold time	tIH (base)	250	_	250	_	275	_	ps	5
Address and control input setup time	tIS (base)	175	_	175	_	200	_	ps	4
Read preamble	tRPRE	0.9	1.1	0.9	1.1	0.9	1.1	tCK (avg)	11
Read postamble	tRPST	0.4	0.6	0.4	0.6	0.4	0.6	tCK (avg)	12
Active to precharge command	tRAS	45	70000	45	70000	45	70000	ns	
Active to auto-precharge delay	tRAP	tRCD min.	_	tRCD min.	_	tRCD min.	_	ns	
Active bank A to active bank B command period	tRRD	7.5	_	7.5	_	7.5	_	ns	
Four active window period	tFAW	35	_	35	_	37.5	_	ns	
/CAS to /CAS command delay	tCCD	2	_	2	_	2	_	nCK	
Write recovery time	tWR	15	_	15	_	15	_	ns	
Auto precharge write recovery + precharge time	tDAL	WR + RU (tRP/ tCK (avg))	_	WR + RU (tRP/ tCK (avg))	_	WR + RU (tRP/ tCK (avg))	_	nCK	1, 9
Internal write to read command delay	tWTR	7.5	_	7.5	_	7.5	_	ns	
Internal read to precharge command delay	tRTP	7.5	_	7.5	_	7.5	_	ns	
Exit self-refresh to a non-read command	tXSNR	tRFC + 10	_	tRFC + 10	_	tRFC + 10	_	ns	
Exit self-refresh to a read command	tXSRD	200	_	200	_	200	_	nCK	
Exit precharge power down to any non-read command	tXP	2	_	2	_	2	_	nCK	
Exit active power down to read command	tXARD	2	_	2	_	2	_	nCK	3
Exit active power down to read command (slow exit/low power mode)	tXARDS	8 – AL	_	8 – AL	_	7 – AL	_	nCK	2, 3
CKE minimum pulse width (high and low pulse width)	tCKE	3	_	3	_	3	_	nCK	
Output impedance test driver delay	tOIT	0	12	0	12	0	12	ns	
MRS command to ODT update delay	tMOD	0	12	0	12	0	12	ns	
Auto-refresh to active/auto-refresh command time	tRFC	127.5	_	127.5	_	127.5	_	ns	
Average periodic refresh interval $(0^{\circ}C \le TC \le +85^{\circ}C)$	tREFI	_	7.8	_	7.8	_	7.8	μs	
$(+85^{\circ}C < TC \le +95^{\circ}C)$	tREFI	_	3.9	_	3.9	_	3.9	μs	
Minimum time clocks remains ON after CKE asynchronously drops low	tDELAY	tIS + tCK(avg) + tIH	_	tIS + tCK(avg) + tIH	_	tIS + tCK(avg) + tIH	_	ns	



Notes: 1. For each of the terms above, if not already an integer, round to the next higher integer.

- 2. AL: Additive Latency.
- 3. MRS A12 bit defines which active power down exit timing to be applied.
- 4. The figures of Input Waveform Timing 1 and 2 are referenced from the input signal crossing at the VIH(AC) level for a rising signal and VIL(AC) for a falling signal applied to the device under test.
- 5. The figures of Input Waveform Timing 1 and 2 are referenced from the input signal crossing at the VIL(DC) level for a rising signal and VIH(DC) for a falling signal applied to the device under test.





Input Waveform Timing 1 (tDS, tDH)

Input Waveform Timing 2 (tIS, tIH)

tHP is the minimum of the absolute half period of the actual input clock. tHP is an input parameter but not an input specification parameter. It is used in conjunction with tQHS to derive the DRAM output timing tQH

The value to be used for tQH calculation is determined by the following equation;

tHP = min (tCH(abs), tCL(abs)),

where,

tCH(abs) is the minimum of the actual instantaneous clock high time;

tCL(abs) is the minimum of the actual instantaneous clock low time;

- 7. tQHS accounts for:
  - a. The pulse duration distortion of on-chip clock circuits, which represents how well the actual tHP at the input is transferred to the output; and
  - b. The worst case push-out of DQS on one transition followed by the worst case pull-in of DQ on the next transition, both of which are independent of each other, due to data pin skew, output pattern effects, and p-channel to n-channel variation of the output drivers.
- 8. tQH = tHP tQHS, where:

tHP is the minimum of the absolute half period of the actual input clock; and tQHS is the specification value under the max column.

{The less half-pulse width distortion present, the larger the tQH value is; and the larger the valid data eye will be.}

Examples:

- a. If the system provides tHP of 1315ps into a DDR2-667 SDRAM, the DRAM provides tQH of 975ps (min.)
- b. If the system provides tHP of 1420ps into a DDR2-667 SDRAM, the DRAM provides tQH of 1080ps (min.)
- 9. RU stands for round up. WR refers to the tWR parameter stored in the MRS.
- 10. When the device is operated with input clock jitter, this parameter needs to be derated by the actual tERR(6-10per) of the input clock. (output deratings are relative to the SDRAM input clock.)

For example, if the measured jitter into a DDR2-667 SDRAM has tERR(6-10per) min. = -272ps and tERR(6-10per) max. = +293ps, then tDQSCK min.(derated) = tDQSCK min. – tERR(6-10per) max. = -400ps – 293ps = -693ps and tDQSCK max.(derated) = tDQSCK max. – tERR(6-10per) min. = 400ps + 272ps = +672ps. Similarly, tLZ(DQ) for DDR2-667 derates to tLZ(DQ) min.(derated) = -900ps – 293ps = -1193ps and tLZ(DQ) max.(derated)= 450ps + 272ps = +722ps.

11. When the device is operated with input clock jitter, this parameter needs to be derated by the actual tJIT(per) of the input clock. (output deratings are relative to the SDRAM input clock.)

For example, if the measured jitter into a DDR2-667 SDRAM has tJIT(per) min. = -72ps and tJIT(per) max. = +93ps, then tRPRE min.(derated) = tRPRE min. + tJIT(per) min. =  $0.9 \times tCK(avg) - 72ps$  = +2178ps and tRPRE max.(derated) = tRPRE max. + tJIT(per) max. =  $1.1 \times tCK(avg) + 93ps$  = +2843ps.

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12. When the device is operated with input clock jitter, this parameter needs to be derated by the actual tJIT(duty) of the input clock. (output deratings are relative to the SDRAM input clock.)

For example, if the measured jitter into a DDR2-667 SDRAM has tJIT(duty) min. = -72ps and tJIT(duty) max. = +93ps, then tRPST min.(derated) = tRPST min. + tJIT(duty) min. = 0.4 × tCK(avg) -

72ps = +928ps and tRPST max.(derated) = tRPST max. + tJIT(duty) max. =  $0.6 \times tCK(avg) + 93ps =$ 

13. Refer to the Clock Jitter table.

+1592ps.



#### ODT AC Electrical Characteristics (DDR2 SDRAM Component Specification)

Parameter	Symbol	min.	max.	Unit	Notes
ODT turn-on delay	tAOND	2	2	tCK	
ODT turn-on	tAON	tAC (min)	tAC (max) + 700	ps	1, 3
ODT turn-on (power down mode)	tAONPD	tAC(min) + 2000	2tCK + tAC(max) + 1000	ps	
ODT turn-off delay	tAOFD	2.5	2.5	tCK	5
ODT turn-off	tAOF	tAC(min)	tAC(max) + 600	ps	2, 4, 5
ODT turn-off (power down mode)	tAOFPD	tAC(min) + 2000	2.5tCK + tAC(max) + 1000	ps	
ODT to power down entry latency	tANPD	3	3	tCK	
ODT power down exit latency	tAXPD	8	8	tCK	

- Notes: 1. ODT turn on time min is when the device leaves high impedance and ODT resistance begins to turn on.

  ODT turn on time max is when the ODT resistance is fully on. Both are measured from tAOND.
  - ODT turn off time min is when the device starts to turn off ODT resistance.ODT turn off time max is when the bus is in high impedance. Both are measured from tAOFD.
  - 3. When the device is operated with input clock jitter, this parameter needs to be derated by the actual tERR(6-10per) of the input clock. (output deratings are relative to the SDRAM input clock.)
  - 4. When the device is operated with input clock jitter, this parameter needs to be derated by {-tJIT(duty) max. tERR(6-10per) max. } and { -tJIT(duty) min. tERR(6-10per) min. } of the actual input clock.(output deratings are relative to the SDRAM input clock.)
    - For example, if the measured jitter into a DDR2-667 SDRAM has tERR(6-10per) min. = -272ps, tERR(6-10per) max. = +293ps, tJIT(duty) min. = -106ps and tJIT(duty) max. = +94ps, then tAOF min.(derated) = tAOF min. + {-tJIT(duty) max. tERR(6-10per) max.} = -450ps + {-94ps 293ps} = -837ps and tAOF max.(derated) = tAOF max. + {-tJIT(duty) min. tERR(6-10per) min.} = 1050ps + {106ps + 272ps} = +1428ps.
  - 5. For tAOFD of DDR2-667/800, the 1/2 clock of nCK in the 2.5 × nCK assumes a tCH(avg), average input clock high pulse width of 0.5 relative to tCK(avg). tAOF min. and tAOF max. should each be derated by the same amount as the actual amount of tCH(avg) offset present at the DRAM input with respect to 0.5. For example, if an input clock has a worst case tCH(avg) of 0.48, the tAOF min. should be derated by subtracting 0.02 × tCK(avg) from it, whereas if an input clock has a worst case tCH(avg) of 0.52, the tAOF max. should be derated by adding 0.02 × tCK(avg) to it. Therefore, we have;

```
tAOF min.(derated) = tAC min. -[0.5 - Min.(0.5, tCH(avg) min.)] \times tCK(avg)
tAOF max.(derated) = tAC max. + 0.6 + [Max.(0.5, tCH(avg) max.) - 0.5] \times tCK(avg)
or
```

 $tAOF \ min. (derated) = Min. (tAC \ min., \ tAC \ min. - [0.5 - tCH(avg) \ min.] \times tCK(avg))$ 

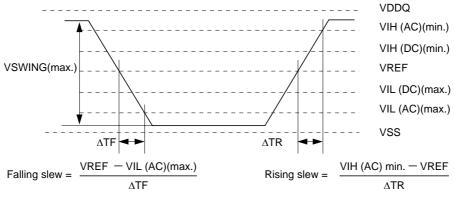
tAOF max.(derated) = 0.6 + Max.(tAC max., tAC max. + [tCH(avg) max. - 0.5] × tCK(avg))

where tCH(avg) min. and tCH(avg) max. are the minimum and maximum of tCH(avg) actually measured at the DRAM input balls.

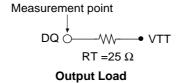
#### **AC Input Test Conditions (DDR2 SDRAM Component Specification)**

Parameter	Symbol	Value	Unit	Notes
Input reference voltage	VREF	$0.5 \times VDDQ$	V	1
Input signal maximum peak to peak swing	VSWING (max.)	1.0	V	1
Input signal minimum slew rate	SLEW	1.0	V/ns	2, 3

- Notes: 1. Input waveform timing is referenced to the input signal crossing through the VIH/IL (AC) level applied to the device under test.
  - 2. The input signal minimum slew rate is to be maintained over the range from VREF to VIH (AC) (min.) for rising edges and the range from VREF to VIL (AC) (max.) for falling edges as shown in the below figure.
  - 3. AC timings are referenced with input waveforms switching from VIL (AC) to VIH (AC) on the positive transitions and VIH (AC) to VIL (AC) on the negative transitions.



**AC Input Test Signal Wave forms** 



#### Clock Jitter [DDR2-800, 667]

		-8E, -8G 800		-6E			
Frequency (Mbps)				667	667		
Parameter	Symbol	min.	max.	min.	max.	Unit	Notes
Average clock period	tCK (avg)	2500	8000	3000	8000	ps	1
Clock period jitter	tJIT (per)	-100	100	-125	125	ps	5
Clock period jitter during DLL locking period	tJIT (per, lck)	-80	80	-100	100	ps	5
Cycle to cycle period jitter	tJIT (cc)	_	200	_	250	ps	6
Cycle to cycle clock period jitter during DLL locking period	tJIT (cc, lck)	_	160	_	200	ps	6
Cumulative error across 2 cycles	tERR (2per)	-150	150	-175	175	ps	7
Cumulative error across 3 cycles	tERR (3per)	-175	175	-225	225	ps	7
Cumulative error across 4 cycles	tERR (4per)	-200	200	-250	250	ps	7
Cumulative error across 5 cycles	tERR (5per)	-200	200	-250	250	ps	7
Cumulative error across n=6,7,8,9,10 cycles	tERR (6-10per)	-300	300	-350	350	ps	7
Cumulative error across n=11, 12,49,50 cycles	tERR (11-50per)	-450	450	-450	450	ps	7
Average high pulse width	tCH (avg)	0.48	0.52	0.48	0.52	tCK (avg)	2
Average low pulse width	tCL (avg)	0.48	0.52	0.48	0.52	tCK (avg)	3
Duty cycle jitter	tJIT (duty)	-100	100	-125	125	ps	4

Notes: 1. tCK (avg) is calculated as the average clock period across any consecutive 200cycle window.

$$tCK(avg) = \left\{ \sum_{j=1}^{N} tCKj \right\} / N$$

$$N = 200$$

2. tCH (avg) is defined as the average high pulse width, as calculated across any consecutive 200 high pulses.

$$tCH(avg) = \left\{ \sum_{j=1}^{N} tCHj \right\} / (N \times tCK(avg))$$

$$N = 200$$

3. tCL (avg) is defined as the average low pulse width, as calculated across any consecutive 200 low pulses.

$$tCL(avg) = \left\{ \sum_{j=1}^{N} tCLj \right\} / (N \times tCK(avg))$$

$$N = 200$$

4. tJIT (duty) is defined as the cumulative set of tCH jitter and tCL jitter. tCH jitter is the largest deviation of any single tCH from tCH (avg). tCL jitter is the largest deviation of any single tCL from tCL (avg). tJIT (duty) is not subject to production test.

tJIT (duty) = Min./Max. of {tJIT (CH), tJIT (CL)}, where:

tJIT (CH) =  $\{tCH_i - tCH \text{ (avg) where } j = 1 \text{ to } 200\}$ 

 $tJIT (CL) = \{tCL_i - tCL (avg) \text{ where } j = 1 \text{ to } 200\}$ 

5. tJIT (per) is defined as the largest deviation of any single tCK from tCK (avg).

tJIT (per) = Min./Max. of {  $tCK_i - tCK$  (avg) where j = 1 to 200}

tJIT (per) defines the single period jitter when the DLL is already locked. tJIT (per, lck) uses the same definition for single period jitter, during the DLL locking period only. tJIT (per) and tJIT (per, lck) are not subject to production test.

6. tJIT (cc) is defined as the absolute difference in clock period between two consecutive clock cycles:

tJIT (cc) = Max. of  $|tCK_{i+1} - tCK_i|$ 

- tJIT (cc) is defines the cycle to cycle jitter when the DLL is already locked. tJIT (cc, lck) uses the same definition for cycle to cycle jitter, during the DLL locking period only. tJIT (cc) and tJIT (cc, lck) are not subject to production test.
- 7. tERR (nper) is defined as the cumulative error across multiple consecutive cycles from tCK (avg). tERR (nper) is not subject to production test.

$$tERR(nper) = \left\{ \sum_{j=1}^{n} tCKj \right\} - n \times tCK(avg)$$

 $2 \le n \le 50$  for tERR (nper)

8. These parameters are specified per their average values, however it is understood that the following relationship between the average timing and the absolute instantaneous timing hold at all times. (minimum and maximum of spec values are to be used for calculations in the table below.)

Parameter	Symbol	min.	max.	Unit
Absolute clock period	tCK (abs)	tCK (avg) min. + tJIT (per) min.	tCK (avg) max. + tJIT (per) max.	ps
Absolute clock high pulse width	tCH (abs)	tCH (avg) min. × tCK (avg) min. + tJIT (duty) min.	tCH (avg) max. × tCK (avg) max. + tJIT (duty) max.	ps
Absolute clock low pulse width	tCL (abs)	tCL (avg) min. × tCK (avg) min. + tJIT (duty) min.	tCL (avg) max. $\times$ tCK (avg) max. + tJIT (duty) max.	ps

Example: For DDR2-667, tCH(abs) min. =  $(0.48 \times 3000 \text{ ps}) - 125 \text{ps} = 1315 \text{ps}$ 

#### **Pin Functions**

#### CK, /CK (input pin)

The CK and the /CK are the master clock inputs. All inputs except DMs, DQSs and DQs are referred to the cross point of the CK rising edge and the VREF level. When a read operation, DQSs and DQs are referred to the cross point of the CK and the /CK. When a write operation, DMs and DQs are referred to the cross point of the DQS and the VREF level. DQSs for write operation are referred to the cross point of the CK and the /CK.

#### /CS (input pin)

When /CS is low, commands and data can be input. When /CS is high, all inputs are ignored. However, internal operations (bank active, burst operations, etc.) are held.

#### /RAS, /CAS, and /WE (input pins)

These pins define operating commands (read, write, etc.) depending on the combinations of their voltage levels. See "Command operation".

#### A0 to A13 (input pins)

Row address (AX0 to AX13) is determined by the A0 to the A13 level at the cross point of the CK rising edge and the VREF level in a bank active command cycle. Column address (AY0 to AY9) is loaded via the A0 to the A9 at the cross point of the CK rising edge and the VREF level in a read or a write command cycle. This column address becomes the starting address of a burst operation.

#### A10 (AP) (input pin)

A10 defines the precharge mode when a precharge command, a read command or a write command is issued. If A10 = high when a precharge command is issued, all banks are precharged. If A10 = low when a precharge command is issued, only the bank that is selected by BA1, BA0 is precharged. If A10 = high when read or write command, auto-precharge function is enabled. While A10 = low, auto-precharge function is disabled.

#### BA0, BA1, BA2 (input pin)

BA0, BA1 and BA2 are bank select signals (BA). The memory array is divided into 8 banks: bank 0 to bank 7. (See Bank Select Signal Table)

#### [Bank Select Signal Table]

	BA0	BA1	BA2	
Bank 0	L	L	L	
Bank 1	Н	L	L	
Bank 2	L	Н	L	
Bank 3	Н	Н	L	
Bank 4	L	L	Н	
Bank 5	Н	L	Н	
Bank 6	L	Н	Н	
Bank 7	Н	Н	Н	

Remark: H: VIH. L: VIL.

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#### CKE (input pin)

CKE controls power down and self-refresh. The power down and the self-refresh commands are entered when the CKE is driven low and exited when it resumes to high.

The CKE level must be kept for 1 CK cycle at least, that is, if CKE changes at the cross point of the CK rising edge and the VREF level with proper setup time tIS, at the next CK rising edge CKE level must be kept with proper hold time tIH.

## DQ and CB (input and output pins)

Data are input to and output from these pins.

#### DQS and /DQS (input and output pin)

DQS and /DQS provide the read data strobes (as output) and the write data strobes (as input).

#### DM (input pins)

DM is the reference signal of the data input mask function. DMs are sampled at the cross point of DQS and /DQS.

#### VDD (power supply pins)

1.8V is applied. (VDD is for the internal circuit.)

#### VDDSPD (power supply pin)

1.8V is applied (For serial EEPROM).

#### VSS (power supply pin)

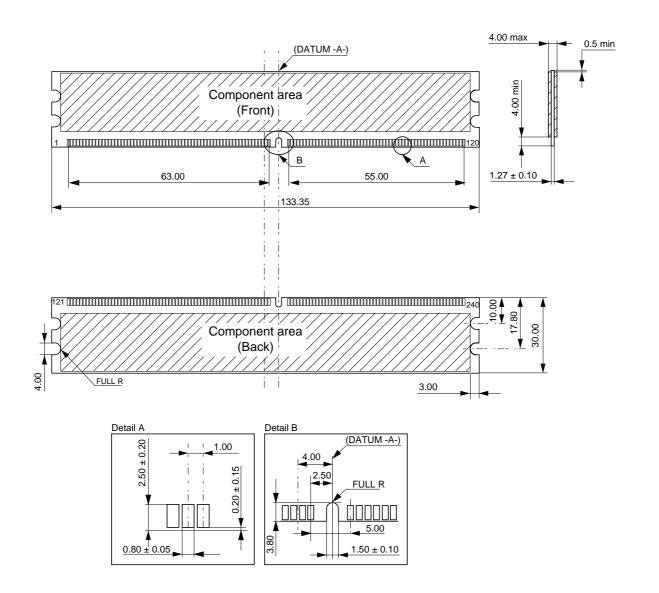
Ground is connected.

#### **Detailed Operation Part and Timing Waveforms**

Refer to the EDE1104ACSE, EDE1108ACSE, EDE1116ACSE datasheet (E0975E).

## **Physical Outline**

Unit: mm



ECA-TS2-0093-01

#### **CAUTION FOR HANDLING MEMORY MODULES**

When handling or inserting memory modules, be sure not to touch any components on the modules, such as the memory ICs, chip capacitors and chip resistors. It is necessary to avoid undue mechanical stress on these components to prevent damaging them.

In particular, do not push module cover or drop the modules in order to protect from mechanical defects, which would be electrical defects.

When re-packing memory modules, be sure the modules are not touching each other.

Modules in contact with other modules may cause excessive mechanical stress, which may damage the modules.

MDE0202

#### NOTES FOR CMOS DEVICES -

#### 1 PRECAUTION AGAINST ESD FOR MOS DEVICES

Exposing the MOS devices to a strong electric field can cause destruction of the gate oxide and ultimately degrade the MOS devices operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it, when once it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. MOS devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. MOS devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor MOS devices on it.

### (2) HANDLING OF UNUSED INPUT PINS FOR CMOS DEVICES

No connection for CMOS devices input pins can be a cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. The unused pins must be handled in accordance with the related specifications.

#### 3 STATUS BEFORE INITIALIZATION OF MOS DEVICES

Power-on does not necessarily define initial status of MOS devices. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the MOS devices with reset function have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. MOS devices are not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for MOS devices having reset function.

CME0107



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#### [Usage environment]

Usage in environments with special characteristics as listed below was not considered in the design. Accordingly, our company assumes no responsibility for loss of a customer or a third party when used in environments with the special characteristics listed below.

#### Example:

- 1) Usage in liquids, including water, oils, chemicals and organic solvents.
- 2) Usage in exposure to direct sunlight or the outdoors, or in dusty places.
- 3) Usage involving exposure to significant amounts of corrosive gas, including sea air, CL<sub>2</sub>, H<sub>2</sub>S, NH<sub>3</sub>, SO<sub>2</sub>, and NO<sub>x</sub>.
- 4) Usage in environments with static electricity, or strong electromagnetic waves or radiation.
- 5) Usage in places where dew forms.
- 6) Usage in environments with mechanical vibration, impact, or stress.
- 7) Usage near heating elements, igniters, or flammable items.

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M01E0706

